

Brittleness and Robustness of Bayesian Inference

Tim Sullivan

with Houman Owhadi and Clint Scovel (Caltech)

Mathematics Institute, University of Warwick

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What Do We Mean by 'Bayesian Brittleness'?

- Bayesian procedures give posterior distributions for quantities of interest in the form of Bayes' rule

$$p(\text{parameters}|\text{data}) \propto L(\text{data}|\text{parameters})p(\text{parameters})$$

given the following data:

- ▶ a **prior probability distribution** on parameters — later denoted $u \in \mathbb{U}$;
 - ▶ a **likelihood function**;
 - ▶ **observations / data** — later denoted $y \in \mathbb{Y}$.
- It is natural to ask about the **robustness, stability, and accuracy** of such procedures.
 - This is a subtle topic, with **both positive and negative results**, especially for large/complex systems, with fine geometrical and topological considerations playing a key role.

What Do We Mean by 'Bayesian Brittleness'?

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- **Frequentist** questions: If the data are generated from some 'true' distribution, will the posterior eventually/asymptotically identify the 'true' value? Are Bayesian credible sets also frequentist confidence sets? What if the model class doesn't even contain the 'truth'?
- **Numerical analysis** questions: Is Bayesian inference a well-posed problem, in the sense that small perturbations of the prior, likelihood, or data (e.g. those arising from numerical discretization) lead to small changes in the posterior? Can effective estimates be given?
- For us, '**brittleness**' simply means the **strongest possible negative result**: under arbitrarily small perturbations of the problem setup the posterior conclusions change as much as possible — i.e. extreme discontinuity. (More precise definition later on.)

- 1 Bayesian Inversion and Frequentist Consistency
- 2 Bayesian Brittleness
- 3 Closing Remarks

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Bayesian Modelling Setup

- Parameter space \mathbb{U} , equipped with a **prior** $\pi \in \mathcal{P}(\mathbb{U})$.
- Observed data with values in \mathbb{Y} are explained using a **likelihood model**, i.e. a function $L: \mathbb{U} \rightarrow \mathcal{P}(\mathbb{Y})$ with

$$L(E|u) = \mathbb{P}[y \in E | u].$$

- This defines a (non-product) **joint measure** μ on $\mathbb{U} \times \mathbb{Y}$ by

$$\mu(E) := \mathbb{E}_{u \sim \pi, y \sim L(\cdot | u)} [\mathbb{1}_E(u, y)] \equiv \int_{\mathbb{U}} \int_{\mathbb{Y}} \mathbb{1}_E(u, y) L(dy|u) \pi(du).$$

- The **Bayesian posterior** on \mathbb{U} is just μ conditioned on a \mathbb{Y} -fibre, and re-normalized to be a probability measure. **Bayes' Rule** gives this as

$$\pi(E|y) = \frac{\mathbb{E}_{u \sim \pi} [\mathbb{1}_E(u) L(y|u)]}{\mathbb{E}_{u \sim \pi} [L(y|u)]}.$$

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$$\frac{d\pi(\cdot | y)}{d\pi} \propto L(y | \cdot).$$

Traditional Setting

\mathbb{U} is a finite set or \mathbb{R}^d for small $d \in \mathbb{N}$.

More Modern Applications

A very high-dimensional or infinite-dimensional \mathbb{U} , e.g. an inverse problem for a PDE:

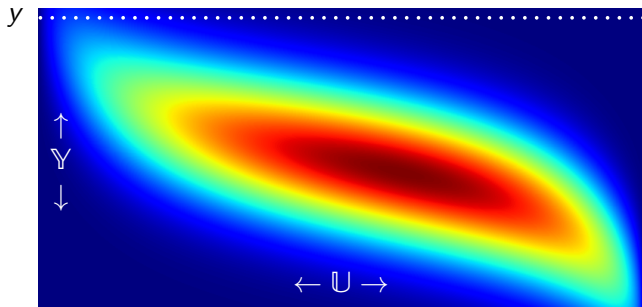
$$\begin{aligned} -\nabla \cdot (u \nabla p) &= f, \\ \text{boundary conditions}(p) &= 0. \end{aligned}$$

in which we attempt to infer the permeability u from e.g. some noisy point observations of the pressure/head p .

Prior measure π on \mathbb{U} :



Joint measure μ on $\mathbb{U} \times \mathbb{Y}$:



Posterior measure $\pi(\cdot | y) \propto \mu|_{\mathbb{U} \times \{y\}}$ on \mathbb{U} :



Specification of Bayesian Models

- Parameter space \mathbb{U} , equipped with a **prior** $\pi \in \mathcal{P}(\mathbb{U})$.
- Observed data with values in \mathbb{Y} are explained using a **likelihood model**, i.e. a function $L: \mathbb{U} \rightarrow \mathcal{P}(\mathbb{Y})$ with

$$L(E|u) = \mathbb{P}[y \in E \mid u].$$

Definition (Frequentist well-specification)

If data are generated according to $\mu^\dagger \in \mathcal{P}(\mathbb{Y})$, then the Bayesian model is called **well-specified** if there is some $u^\dagger \in \mathbb{U}$ such that $\mu^\dagger = L(\cdot | u^\dagger)$; otherwise, the model is called **misspecified**.

Consistency of Bayesian Models

Suppose that the observed data consists of a sequence of independent μ^\dagger -distributed samples (y_1, y_2, \dots) , and let

$$\pi^{(n)}(u) := \pi(u|y_1, \dots, y_n) \propto L(y_1, \dots, y_n|u)\pi(u)$$

be the posterior measure obtained by conditioning the prior π with respect to the first n observations using Bayes' rule.

Definition (Frequentist consistency)

A well-specified Bayesian model with $\mu^\dagger = L(\cdot | u^\dagger)$ is called **consistent** (in an appropriate topology on $\mathcal{P}(\mathbb{U})$) if

$$\lim_{n \rightarrow \infty} \pi^{(n)} = \delta_{u^\dagger},$$

i.e. the posterior asymptotically gives full mass to the true parameter value.

Bernstein–von Mises Theorem

The classic positive result regarding posterior consistency is the **Bernstein–von Mises theorem** or **Bayesian CLT**, historically first envisioned by **Laplace** (1810) and first rigorously proved by **Le Cam** (1953):

Theorem (Bernstein–von Mises)

If \mathbb{U} and \mathbb{Y} are finite-dimensional, then, subject to regularity assumptions on L and π , any well-specified Bayesian model is consistent provided $u^\dagger \in \text{supp}(\pi)$. Furthermore, $\pi^{(n)}$ is asymptotically normal about $\hat{u}_n^{\text{MLE}} \rightarrow u^\dagger$, with precision proportional to the Fisher information $\mathcal{I}(u^\dagger)$:

$$\mathbb{P}_{y_i \sim \mu^\dagger} \left[\left\| \pi^{(n)} - \mathcal{N} \left(\hat{u}_n^{\text{MLE}}, \frac{\mathcal{I}(u^\dagger)^{-1}}{n} \right) \right\|_{\text{TV}} > \varepsilon \right] \xrightarrow{n \rightarrow \infty} 0,$$

where
$$\mathcal{I}(u^\dagger)_{ij} = \mathbb{E}_{y \sim L(\cdot | u^\dagger)} \left[\frac{\partial \log L(y|u)}{\partial u_i} \frac{\partial \log L(y|u)}{\partial u_j} \Bigg|_{u=u^\dagger} \right].$$

Bernstein–von Mises Theorem

- Informally, the BvM theorem says that a well-specified model is capable of learning any ‘truth’ in the support of the prior.
- If we obey Cromwell’s Rule
 - “*I beseech you, in the bowels of Christ, think it possible that you may be mistaken.*”
 - by choosing a globally supported prior π , then everything should turn out OK — and the limiting posterior should be **independent of π** .
- Unfortunately, the BvM theorem is **not always true if $\dim \mathbb{U} = \infty$** , even for globally supported priors — but **nor is it always false**.
- Applications of Bayesian methods in function spaces are increasingly popular, so it is important to understand the precise circumstances in which we do or do not have the BvM property.

Some Positive and Negative Consistency Results

Positive

- **Barron, Schervish & Wasserman** (1999): K–L and Hellinger
- **Castillo & Rousseau** and **Nickl & Castillo** (2013): Gaussian seq. space model, modified ℓ^2 balls
- **Szabó, Van der Vaart, Van Zanten** (2014)
- **Stuart & al.** (2010+): Gaussian / Besov measures
- Dirichlet processes

Negative

- **Freedman** (1963, 1965): prior supported on $\mathcal{P}(\mathbb{N}_0)$ sees i.i.d. $y_i \sim \text{Geom}(\frac{1}{4})$, but posterior $\rightarrow \text{Geom}(\frac{3}{4})$
- **Diaconis & Freedman** (1998): such ‘bad’ priors are of small measure, but are topologically generic
- **Johnstone** (2010) and **Leahu** (2011): further Freedman-type results
- \rightarrow **Owhadi, Scovel & S.**

Main moral: the **geometry and topology play a critical role** in consistency.

Consistency of Misspecified Bayesian Models

- By definition, if the model is mis-specified, then we cannot hope for posterior consistency in the sense that $\pi^{(n)} \rightarrow \delta_{u^\dagger}$ where $L(\cdot | u^\dagger) = \mu^\dagger$, because no such $u^\dagger \in \mathbb{U}$ exists.
- However, we can still hope that $\pi^{(n)} \rightarrow \delta_{\hat{u}}$ for some ‘meaningful’ $\hat{u} \in \mathbb{U}$, and that we get **consistent estimates for the values of suitable quantities of interest**, e.g. the posterior asymptotically puts all mass on $\hat{u} \in \mathbb{U}$ such that $L(\cdot | \hat{u})$ matches the mean and variance of μ^\dagger , if not the exact distribution.
- For example, **Berk** (1966, 1970), **Kleijn & Van der Vaart** (2006), **Shalizi** (2009) have results of the type:

Theorem (Minimum relative entropy)

Under suitable regularity assumptions, the posterior concentrates on

$$\hat{u} \in \arg \min \left\{ D_{\text{KL}}(\mu^\dagger \| L(\cdot | u)) \mid u \in \text{supp}(\pi_0) \right\}.$$

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Setup for Brittleness

- For simplicity, \mathbb{U} and \mathbb{Y} will be complete and separable metric spaces — see [arXiv:1304.6772](https://arxiv.org/abs/1304.6772) for weaker but more verbose assumptions.
- Fix a prior $\pi_0 \in \mathcal{P}(\mathbb{U})$ and likelihood model L_0 , and the induced joint measure (Bayesian model) μ_0 ; we will consider other models μ_α ‘near’ to μ_0 .
- Given π_0 and any quantity of interest $q: \mathbb{U} \rightarrow \mathbb{R}$,

$$\pi_0\text{-ess inf}_{u \in \mathbb{U}} q(u) := \sup \{ t \in \mathbb{R} \mid q(u) \geq t \text{ } \pi_0\text{-a.s.} \},$$

$$\pi_0\text{-ess sup}_{u \in \mathbb{U}} q(u) := \inf \{ t \in \mathbb{R} \mid q(u) \leq t \text{ } \pi_0\text{-a.s.} \}.$$

- To get around difficulties of data actually having measure zero, and with one eye on the fact that real-world data is always discretized to some precision level $0 < \delta < \infty$, we assume that our observation is actually that the ‘exact’ data lies in a metric ball $\mathbb{B}_\delta(y) \subseteq \mathbb{Y}$.
- Slight modification: y could actually be $(y_1, \dots, y_n) \in \mathbb{Y}^n$.

The brittleness theorem covers three notions of closeness between models:

- **total variation distance:** for $\alpha > 0$ (small), $\|\mu_0 - \mu_\alpha\|_{\text{TV}} < \alpha$; or
- **Prohorov distance:** for $\alpha > 0$ (small), $d_\Pi(\mu_0, \mu_\alpha) < \alpha$ (for separable \mathbb{U} , this metrizes the weak convergence topology on $\mathcal{P}(\mathbb{U})$); or
- **common moments:** for $\alpha \in \mathbb{N}$ (large), for prescribed measurable functions $\phi_1, \dots, \phi_\alpha: \mathbb{U} \times \mathbb{Y} \rightarrow \mathbb{R}$,

$$\mathbb{E}_{\mu_0}[\phi_i] = \mathbb{E}_{\mu_\alpha}[\phi_i] \quad \text{for } i = 1, \dots, \alpha,$$

or, for $\varepsilon_i > 0$,

$$|\mathbb{E}_{\mu_0}[\phi_i] - \mathbb{E}_{\mu_\alpha}[\phi_i]| \leq \varepsilon_i \quad \text{for } i = 1, \dots, \alpha.$$

Theorem (Brittleness)

Suppose that the original model (π_0, L_0) permits observed data to be arbitrarily unlikely in the sense that

$$\lim_{\delta \rightarrow 0} \sup_{\substack{y \in \mathbb{Y} \\ u \in \text{supp}(\pi_0) \subseteq \mathbb{U}}} L_0(\mathbb{B}_\delta(y) \mid u) = 0, \quad (\text{AU})$$

and let $q: \mathbb{U} \rightarrow \mathbb{R}$ be any measurable function. Then, for all

$$v \in \left[\pi_0\text{-ess inf}_{u \in \mathbb{U}} q(u), \pi_0\text{-ess sup}_{u \in \mathbb{U}} q(u) \right],$$

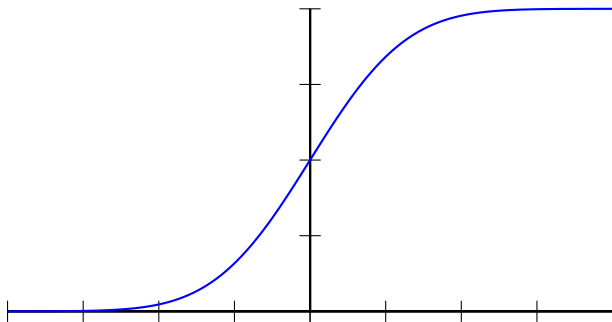
and all $\alpha > 0$, there exists $\delta_*(\alpha) > 0$ and a model μ_α ' α -close' to μ_0 such that the posterior value $\mathbb{E}_{\pi_\alpha} [q \mid \mathbb{B}_\delta(y)]$ for q given data of precision $0 < \delta < \delta_*(\alpha)$ is the chosen value v .

Idea of Proof

- Optimize over the set \mathcal{A}_α of models that are α -close to the original model. (Cf. construction of Bayesian least favourable priors and frequentist minimax estimators.)
- This involves understanding **extreme points of \mathcal{A}_α** and the optimization of affine functionals over such sets — Choquet theory and results of **von Weizsäcker & Winkler** — and previous work by S. and collaborators on Optimal UQ (*SIAM Rev.*, 2013).
- The three notions of closeness considered (moments, Prohorov, TV), plus the (AU) condition, together permit models $\mu_\alpha \in \mathcal{A}_\alpha$ to **'choose which data to trust'** when forming the posterior.
- In our proof as written, the perturbations used to produce the 'bad' models use **point masses**; a slight variation would produce the same result using absolutely continuous perturbations.

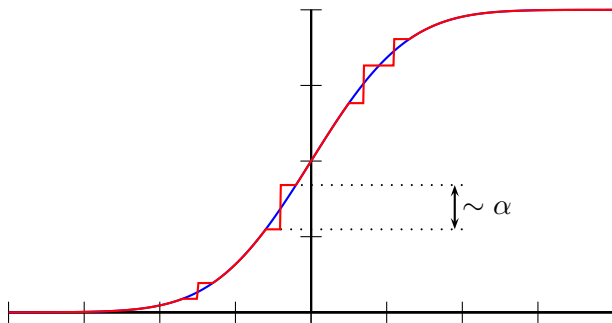
Brittleness Theorem — Proof Sketch

Schematically, the perturbation from μ_0 to μ_α looks like



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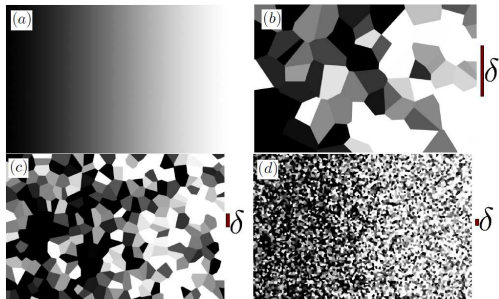
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Brittleness Theorem — Interpretation

- Misspecification has profound consequences for Bayesian robustness on ‘large’ spaces — in fact, Bayesian inferences become extremely brittle as a function of **measurement resolution δ** .
- If the model is misspecified, and there are possible observed data that are arbitrarily unlikely under the model, then under fine enough measurement resolution the posterior predictions of nearby priors **differ as much as possible** *regardless of the number of samples observed*.

Figure. As measurement resolution $\delta \rightarrow 0$, the smooth dependence of $\mathbb{E}_{\pi_0}[q]$ on the prior π_0 (top-left) shatters into a patchwork of diametrically opposed posterior values $\mathbb{E}_{\pi_{(n)}}[q] \equiv \mathbb{E}_{\pi_0}[q|\mathbb{B}_\delta(y)]$.



Brittleness Rates — A Moment-Based Example

- Estimate the mean of a random variable X , taking values in $[0, 1]$, given a single observation y of X
- Set \mathcal{A} of admissible priors for the law of X : anything that gives uniform measure to the mean, uniform measure to the second moment given the mean, uniform measure to the third moment given the second, \dots up to k^{th} moment. (Note that $\dim \mathcal{A} = \infty$ but $\text{codim } \mathcal{A} = k$.)
- So, in particular, for any prior $\pi \in \mathcal{A}$, $\mathbb{E}_\pi[\mathbb{E}[X]] = \frac{1}{2}$.
- Can find priors $\pi_1, \pi_2 \in \mathcal{A}$ with

$$\mathbb{E}_{\pi_1}[\mathbb{E}[X]|y] \leq 4e \left[\frac{2k\delta}{e} \right]^{\frac{1}{2k+1}} \approx 0,$$

$$\mathbb{E}_{\pi_2}[\mathbb{E}[X]|y] \geq 1 - 4e \left[\frac{2k\delta}{e} \right]^{\frac{1}{2k+1}} \approx 1.$$

Ways to Restore Robustness and Consistency

Or: What Would Break This Argument?

- Restrict to **finite-precision data**, i.e. keep δ bounded away from zero. Physically quite reasonable. The universe may be granular enough that $\delta^{1/(2k+1)} \gg 0$ for all 'practical' $\delta > 0$.
- Ask the robustness question **before** seeing the data, not after. This leads to a very large minimax problem, the computation of data-schema-specific **optimal statistical estimators**.
- Ask the robustness question about the **limiting posterior**, not each $\pi^{(n)}$ individually. The **brittleness theorem** and " **$\lim_{n \rightarrow \infty}$** " **might not commute**.

Closing Remarks on Brittleness

- In contrast to the classical robustness and consistency results for Bayesian inference for discrete or finite-dimensional systems, the situation for infinite-dimensional spaces is *complicated*.
- Bayesian inference is **extremely brittle in some topologies**, and so cannot be consistent, and high-precision data only worsens things.
- **Consistency can hold for complex systems**, with *careful* choices of prior, geometry and topology — but, since the situation is so sensitive, **all assumptions must be considered carefully**.
- And, once a ‘mathematical’ prior is agreed upon, just as with classical numerical analysis of algorithms for ODEs and PDEs, the **onus is on the algorithm designer** to ensure that the ‘numerical’ prior is close to the ‘mathematical’ one in a ‘good’ topology.

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Some Questions

- What happens if we do the physically reasonable thing of restricting to **finite-precision data**, i.e. keeping δ bounded away from zero? — Need quantitative versions of these theorems! The one-dimensional k -moments example suggests that the rate is not too bad, but what is the general picture?
- What happens if we ask the robustness question *before* seeing the data, not after?
- What happens if we ask the robustness question about the limiting posterior, not each $\pi^{(n)}$ individually? The **brittleness theorem and “ $\lim_{n \rightarrow \infty}$ ” might not commute.**
- How does this relate to the phenomenon of **Bayesian dilation**?

Thank You

- H. Owhadi & C. Scovel, [arXiv:1304.7046](#)
- H. Owhadi, C. Scovel & T. J. Sullivan, [arXiv:1304.6772](#)
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- T. J. Sullivan, M. McKerns, D. Meyer, F. Theil, H. Owhadi & M. Ortiz, *Math. Model. Numer. Anal.* **47**(6):1657–1689, 2013. [arXiv:1202.1928](#)